

Search Notes

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Examiner

Lan Nguyen

Applicant(s)/Patent under
Reexamination

NAIK ET AL.

Art Unit

3683

SEARCHED

Class	Subclass	Date	Examiner
303	122.07	1/16/2008	XLN

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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